



## MOSFET Push-Pull Hybrid

The DRF1311 is a push-pull hybrid containing two high power gate drivers and two power MOSFETs. It was designed to provide the system designer increased flexibility, higher performance, and lowered cost over a non-integrated solution. This low parasitic approach, coupled with the Schmitt trigger input, Kelvin signal ground, provide improved stability and control in Kilowatt to Multi-Kilowatt, High Frequency ISM applications.

### **Features**

- Switching Frequency: DC TO 30MHz
- Low Pulse Width Distortion
- Single Power Supply (Per Section)
- 1V CMOS Schmitt Trigger Input 1V Hysteresis
- Inverting Non-Inverting Select

- RoHS Compliant
- Switching Speed 3-4ns
- B<sub>Vds</sub> = 1Kv
- I<sub>ds</sub> = 26A avg.
- $R_{DS(on)} \leq .55$  Ohm
- $P_{D} = 1000W$  Per-section

## **Typical Applications**

- Class C, D and E RF Generators
- Switch Mode Power Amplifiers
- Pulse Generators
- Ultrasound Transducer Drivers
- Acoustic Optical Modulators

### **Driver Absolute Maximum Ratings**

Symbol	Parameter	Min	Тур	Мах	Unit
V <sub>dd</sub>	Supply Voltage	8		15	V
IN	Signal Input to Source Voltage	-0.5		V <sub>dd</sub> + 0.3	v
I <sub>орк</sub>	Output Current Peak			15	А
T <sub>JMAX</sub>	Operating Temperature			150	°C

### Driver Specifications (Per-Section) @ $T_c$ = 25

Symbol	Parameter	Min	Тур	Мах	Unit
V <sub>dd</sub>	Supply Voltage	8	12		V
IN <sub>(R)</sub>	Input Voltage Rising Edge		2.5		
IN <sub>(F)</sub>	Input Voltage Falling Edge		2.5		ns
I <sub>DDQ</sub>	Quiescent Current, V <sub>dd</sub> = 12V		15	25	mA
۱ <sub>۵</sub>	Output Current		15		А
C <sub>oss</sub>	Output Capacitance		2500		
C <sub>iss</sub>	Input Capacitance Input		35		рг
R <sub>IN</sub>	Input Parallel Resistance Vin= 5V, V <sub>dd</sub> = 12V		1		MΩ
V <sub>T(ON)</sub>	V Threshold On, V <sub>dd</sub> = 12V, Vin= 0 to 5V Ramp	2.2		3.2	N
V <sub>T(OFF)</sub>	V Threshold Off, V <sub>dd</sub> = 12V, Vin= 5 to 0V Ramp	1.0	1	1.9	v
t,	Rise Time 10% to 90%, $V_{dd}$ = 12V, Vin = 5 to 0V, $R_{L}$ = 1.0 $\Omega$ , $C_{L}$ = 2nF	1.5	2.5	3.0	
t <sub>f</sub>	Fall Time 90% to 10%, $V_{dd}$ = 12V, Vin = 0 to 5V, $R_L$ = 1.0 $\Omega$ , $C_L$ = 2nF	1.5	2.5	3.0	ns
T <sub>D(ON)</sub>	On Delay Time, 50% to 50%, $V_{dd}$ = 12V, Vin = 0 to 5V, RL = 1.0 $\Omega$ , CL = 2nF		18		
T <sub>D(OFF)</sub>	Off Delay Time, 50% to 50%, $V_{dd}$ = 12V, Vin = 0 to 5V, RL = 1.0 $\Omega$ , CL = 2nF		18		

#### Driver Output Characteristics

Symbol	Parameter	Min	Тур	Max	Unit
C <sub>out</sub>	Output Capacitance		2500		pF
R <sub>out</sub>	Output Resistance		0.5		Ω
L <sub>out</sub>	Output Inductance	2	3	4	nH
F <sub>MAX</sub>	Operating Frequency CL = $3nF + 50\Omega$			60	MHz

#### **Driver Thermal Characteristics**

Symbol	Parameter	Min	Тур	Max	Unit
R <sub>θJC</sub>	Thermal Resistance Junction to Case		1.5		°C/W
T <sub>j</sub> , T <sub>stg</sub>	Operating and Storage Temperature	-55		150	°C
P <sub>DC</sub>	Maximum Power Dissipation @ T <sub>C</sub> = 25°C		80		w

#### **MOSFET Absolutes Maximum Ratings (Per-Section)**

Symbol	Parameter	Min	Тур	Max	Unit
BV <sub>DSS</sub>	Drain Source Voltage	1000			V
ا <sub>D</sub>	Continuous Drain Current T <sub>HS</sub> = 25°C			15	А
R <sub>DS(on)</sub>	Drain-Source On State Resistance		1		Ω
T <sub>jmax</sub>	Operating Temperature			175	°C

#### **MOSFET Dynamic Characteristics (Per-Section)**

Symbol	Parameter	Min	Тур	Max	Unit
C <sub>iss</sub>	Input Capacitance, V <sub>DS</sub> = 100V		1650		
C <sub>oss</sub>	Output Capacitance, V <sub>DS</sub> = 100V		158		pF
C <sub>rss</sub>	Reverse Transfer Capacitance, V <sub>DS</sub> = 100V		34		

#### **MOSFET Thermal Characteristics (Total Package)**

Symbol	Parameter	Min	Туре	Max	Unit
R <sub>θJC</sub>	Junction to Case Thermal Resistance		.06		°C/M
R <sub>ØJHS</sub>	Junction to Heat Sink Thermal Resistance		.14		C/W
T <sub>JSTG</sub>	Storage Junction Temperature	-55		150	°C
P <sub>DHS</sub>	Maximum Power Dissipation @ T <sub>SINK</sub> = 25°C		1.07		K)M
P <sub>DC</sub>	Total Power Dissipation @ T <sub>C</sub> = 25°C		2.5		

Per	Per Section Output Switching Performance, All Silicon Devices are Die Selected Temp = 25°C All data is collected using the test circuit as shown in Figure 2					
Symbol	Characteristic	Min	Тур	Мах	Тур	
t <sub>r</sub>	Fall Time 90% to 10% $V_{dd}$ = 12V, $V_{in}$ = 0 to 5V , $V_{DS}$ = 100V, RL = 16.6Ω, CL = 0.4µF	1		2.5		
t,	Rise Time 10% to 90% $V_{dd}$ = 12V, $V_{in}$ = 0 to 5V , $V_{DS}$ = 100V, RL = 16.6Ω, CL = 0.4µF	10		35		
t <sub>DLY(ON)</sub>	ON Delay Time, 50% to 50% $V_{dd}$ = 12V, $V_{in}$ = 0 to 5V , $V_{DS}$ = 100V, RL = 16.6Ω, CL = 0.4µF	35		55	ns	
t <sub>DLY(OFF)</sub>	OFF Delay Time, 50% to 50% $V_{dd}$ = 12V, $V_{in}$ = 0 to 5V, $V_{DS}$ = 100V, RL = 16.6Ω, CL = 0.4µF	50		70		





#### Figure 1, DRF1311 Circuit Diagram

The DRF1311 is configured as a Push Pull Hybrid incorporating two independent channels configured with a common source each consisting of a driver, a high voltage MOSFET and by-pass capacitors. The function of the by-pass capacitors C1 and C2 is to reduce the internal parasitic loop inductance. This coupled with the tight geometry of the hybrid allows optimal gate drive to the MOSFET. This low parasitic approach coupled with the Schmitt trigger input (IN), Kelvin signal ground (SG); provide improved stability and control in Kilowatt to Multi-Kilowatt high frequency applications. The IN pin should be referenced to the Kelvin Ground (SG) and is applied to a Schmitt Trigger. The SG pin is a Kelvin return for the IN pin only. The signal is then applied to the intermediate drivers and level shifters; this section contains proprietary circuitry designed specifically for ring abatement. To further increase the utility of the device the driver die and the MOSFET die are adjacent die selected. This provides a very close match in the turn on and propagation delays.



#### Figure 2, DRF1311 Test Circuit

The test circuit illustrated in Figure 2 was used to evaluate the DRF1311. The input control signal is applied via IN and SG pins using RG188. This provides excellent noise immunity and control of the signal ground currents. The  $+V_{DD}$  inputs (pins 2, 6, 8 and 12) should be heavily by-passed by 1µF capacitors as close to the pins as possible. The capacitors used for this function must be capable of supporting the RMS currents and frequency of the gate load. R<sub>L</sub> set for  $I_{DM}$  at  $V_{DS}$  max this load is used to evaluate the output performance.



Figure 3, Typical Capacitance vs. Drain-to-Source Voltage

Pin A	Pin Assignments				
Pin 1	Ground				
Pin 2	U1 +Vdd				
Pin 3	U1 FN				
Pin 4	U1 IN				
Pin 5	U1 SG				
Pin 6	U1 +Vdd				
Pin 7	Ground				
Pin 8	U2 +Vdd				
Pin 9	U2 FN				
Pin 10	U2 IN				
Pin 11	U2 SG				
Pin 12	U2 +Vdd				
Pin 13	Ground				
Pin 14	Source				
Pin 15	U2 Drain				
Pin 16	Source				
Pin 17	U1 Drain				
Pin 18	Source				

None of the inputs to U1 or U2 of the DRF1311 are isolated for direct connection to a ground referenced power supply or control circuitry. **Isolation appropriate to the application is the responsibility of the end user.** It is imperative that high output currents be restricted to the Source (14, 16, 18) and drain (15, 17) pins by design. See DRF100 for more information on Driver IC used in the device.

The Function (FN, pin 3 or pin 9) is the invert or non-invert select Pin, it is Internally held high.

Truth Table * Referenced to SG				
FN (pin 3)	IN (pin 4)	MOSFET U1		
HIGH	HIGH	ON		
HIGH	LOW	OFF		
LOW	HIGH	OFF		
LOW	LOW	ON		

Truth Table * Referenced to SG					
FN (pin 9)	IN (pin 10)	MOSFET U2			
HIGH	HIGH	ON			
HIGH	LOW	OFF			
LOW	HIGH	OFF			
LOW	LOW	ON			





Figure 4, DRF1311 Mechanical

Outline



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